

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination JAEHNE ET AL.	
		Examiner Mark L. Berch	Art Unit 1624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0082561 A1	04-2004	Jaehne et al.	514/210.02
*	B	US-2005/0239766 A1	10-2005	Starke et al.	514/210.02
*	C	US-2005/0267038 A1	12-2005	Glombik et al.	514/016
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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